



# Detector developments for the Super-FRS

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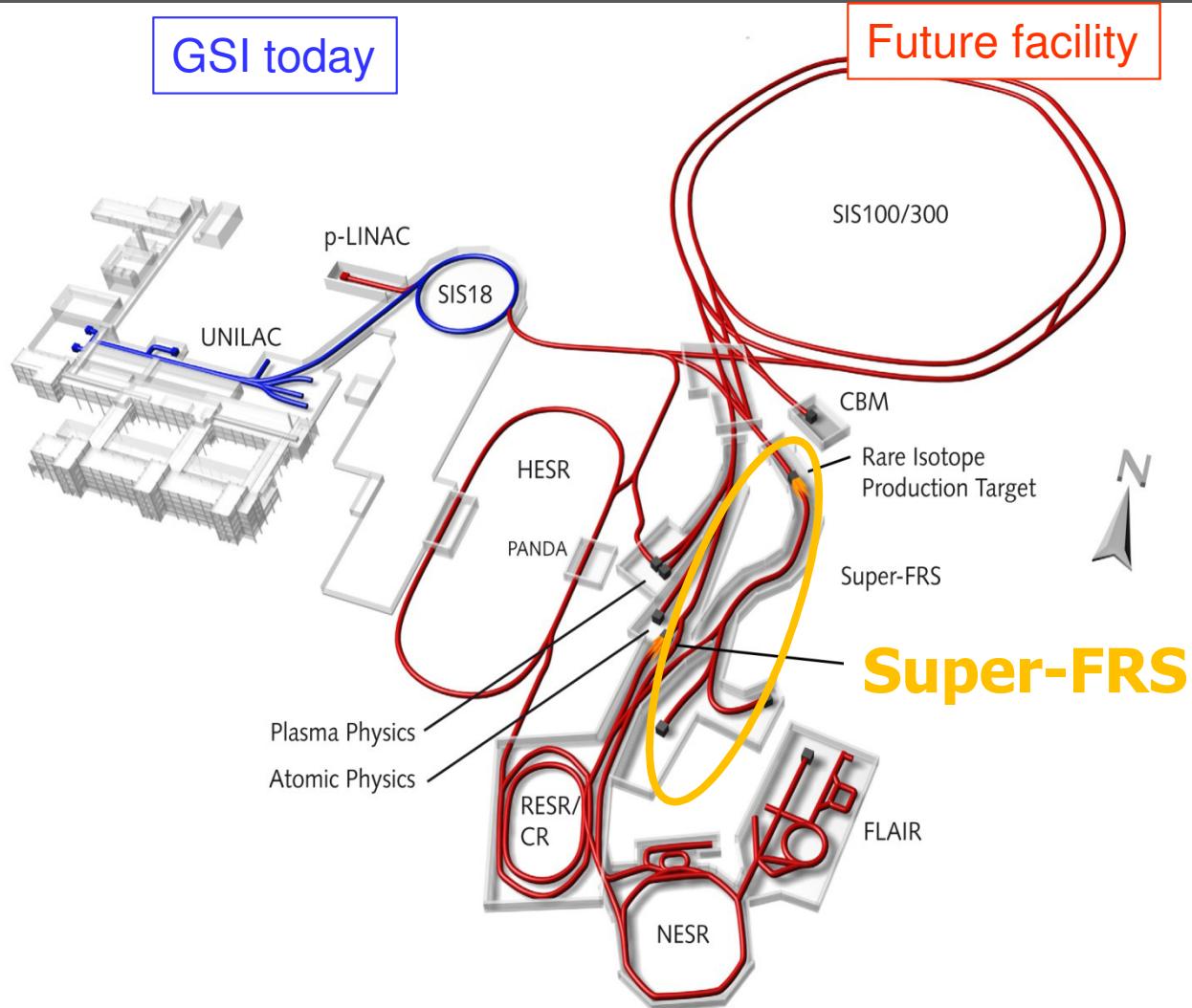
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# Contents

- Introduction to the **Super-FRS** at FAIR
  - new concept in-flight RIB production and separation methods
  - comparison FRS – Super-FRS
- Technical challenges – **high intensity and high resolution** – in particle identification (PID)
- Recent developments & in-beam tests of Super-FRS focal plane detector prototypes.

# The NUSTAR facility at FAIR



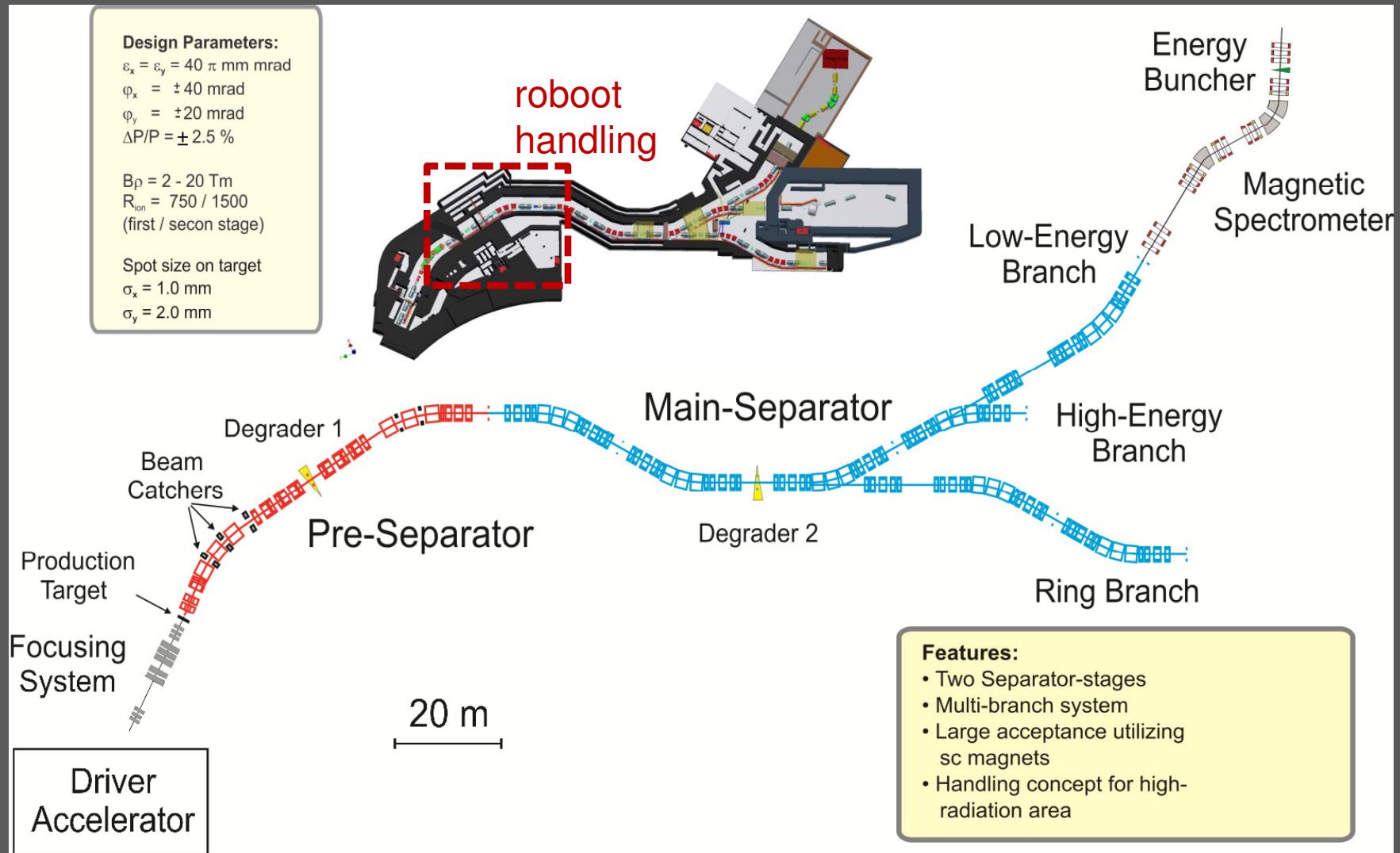
## Primary Beams

- $5 \times 10^{11} {}^{238}\text{U}^{28+}$  (pulsed)  
 $3.5 \times 10^{11} {}^{238}\text{U}^{28+}$  (DC)  
@1.5 GeV/u
- factor **100** in intensity over present

## Secondary Beams

- broad range of RIBs up to 1-2 GeV/u
- up to factor **10000** in intensity over present

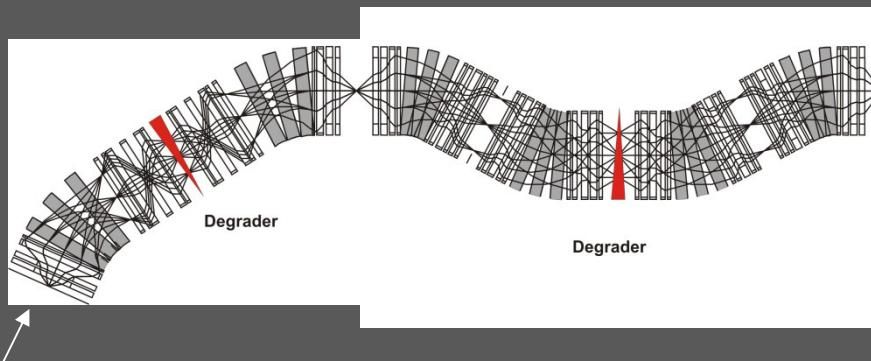
# Layout of the Super-FRS



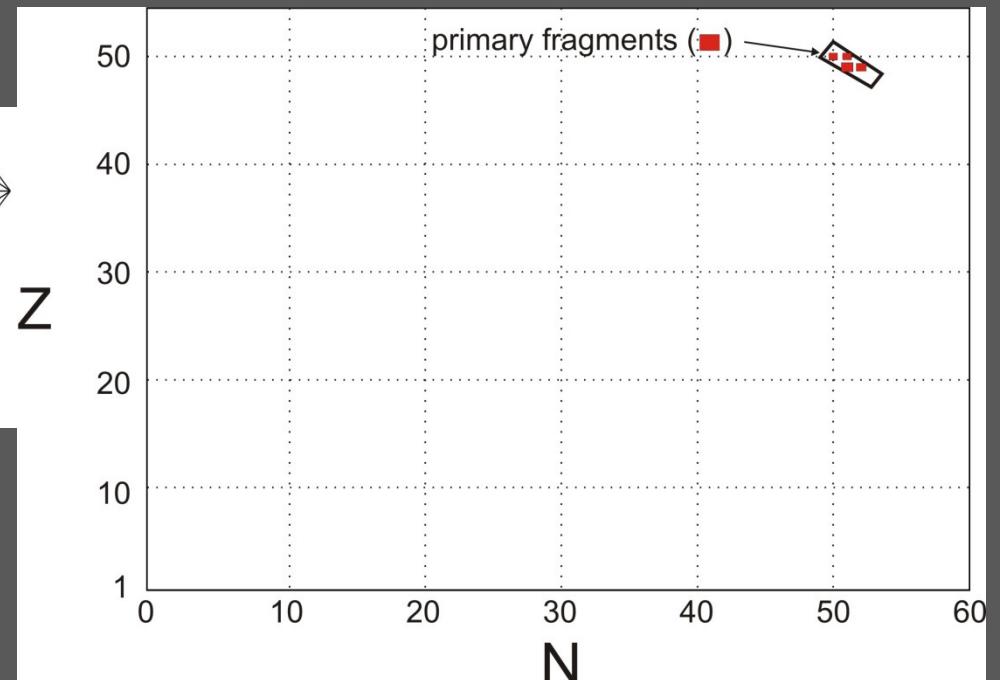
# 2-stage separation

e.g.  $^{100}\text{Sn}$

1-stage separator      2-stage separator

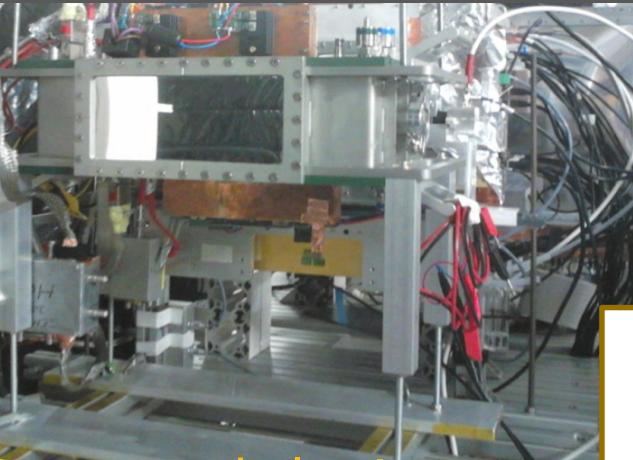


Fragmentation of  $^{124}\text{Xe}$  @ 1 GeV/u



- Strong reduction of contaminants
- Optimization of fragment rate
- Main separator used for secondary reaction studies

# PID detector prototypes

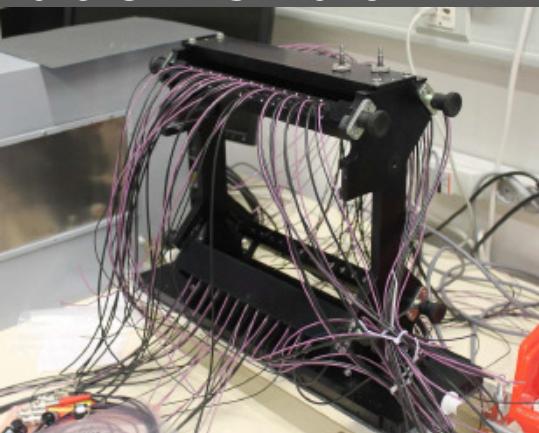


Twin GEM-TPC  
(x, y)  
Partner:  
Helsinki IP



Silicon  
( $\Delta E$ , x, y)  
Partner:  
St. Petersburg

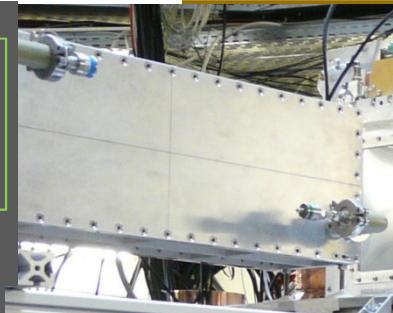
Segmented plastic  
scintillator (ToF)  
Partner: IFJ Krakow



$$Z \leftarrow -dE / dx = f(Z, \beta) \quad \text{atomic number}$$

$$A/Q = \frac{B\rho}{\gamma\beta m_u} \quad Z \neq Q \text{ charge state}$$

**B $\beta$  – ToF –  $\Delta E$   
method**



Triple  
MUSIC  
( $\Delta E$ )  
Partner: CEA

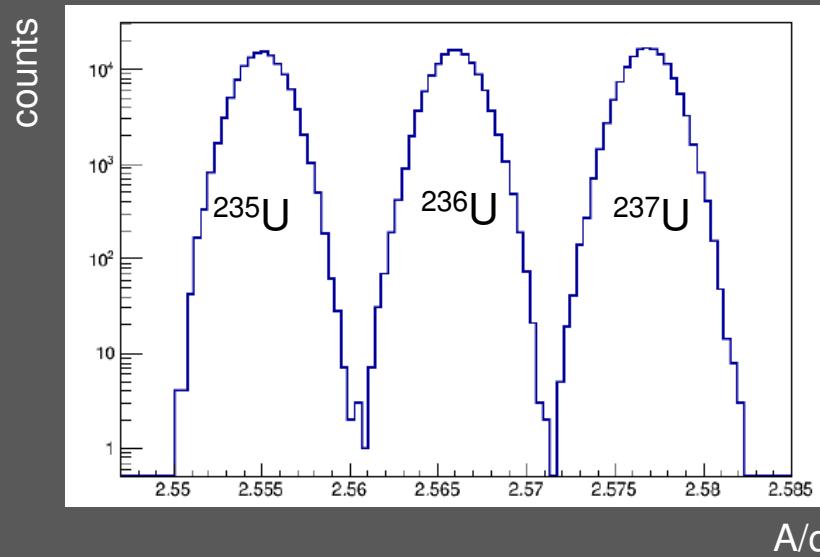
Other diagnostics (ToF)

# Technical challenges

## ■ Clean full PID on event-by-event basis

- momentum tagging  $\Delta x \sim 1\text{mm}$
- ToF measurements  $\Delta \text{ToF} \sim 100\text{ps (FWHM)}$
- charge resolution  $\Delta Z \sim 0.2e$

$$\begin{aligned}\sigma_x &= 0.5\text{mm} \\ \sigma_t &= 20\text{ns}\end{aligned}$$



Monte Carlo  
simulations  
(MOCADI)  
Yields not  
scaled

## ■ Increasing intensity of radioactive beams requires detecting system with high-rate capability

# ToF focal plane detectors



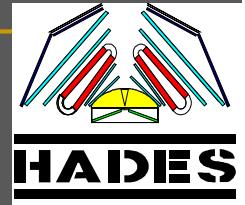
- units working in vacuum
- active area  $10 - 10^4 \text{ mm}^2$
- total rate 1-10 MHz
- high precision time distribution and time stamping over 100 m

## Radiation hard detector (diamond, silicon)

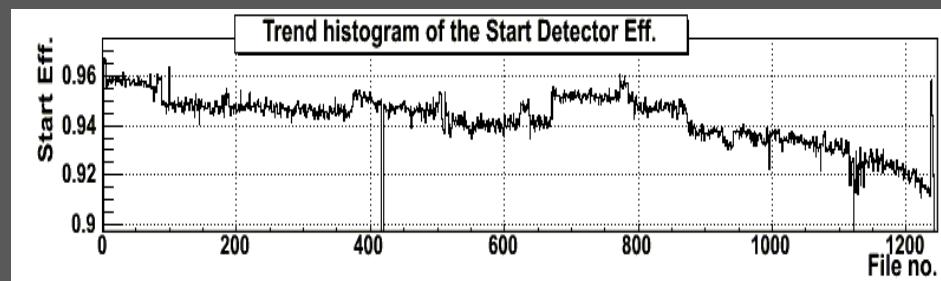
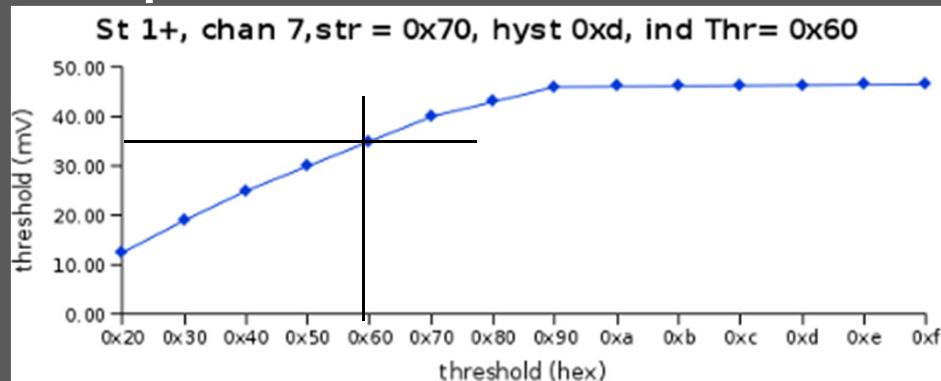
pcCVD-DD     $\longrightarrow$      $(200 \times 40) \text{ mm}^2$  ,   20 units    $20 \times 20 \times 0.3 \text{ mm}^3$

- 100 days operation @1MHz:  $1.08 \times 10^9 \text{ ions/mm}^2$

Absorbed dose =  $4.4 \times 10^5 \text{ Gy}$  ( $^{238}\text{U}$ @350 MeV/u)

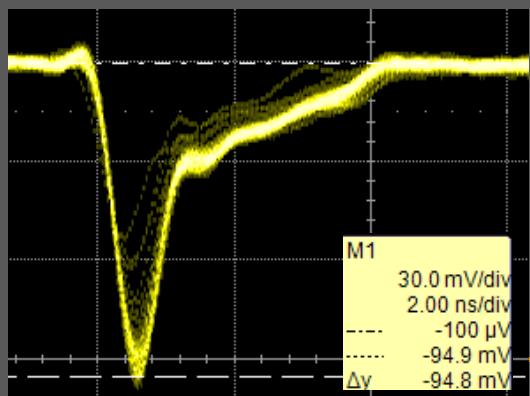


# Radiation hardness study with Au beam - amplitude reduction



Threshold characteristics (Aug11):  
cut amplitudes lower than 35mV

+ 30 % DAQ off + 30 % beam times in 2010  
→ 3.04 x 10<sup>11</sup> Au ions / mm<sup>2</sup>



Analog signals, Au beam, HV: 100V  
Amplitude; 94 mV

→ After 3.04 x 10<sup>11</sup> Au ions /mm<sup>2</sup> about 5% of signals below 35 mV

→ Total absorbed dose : 7.9 Grad (312 MeV / Au ion)

→ Amplitude reduction by a factor of 2.7

→ Precise CCE measurement needed

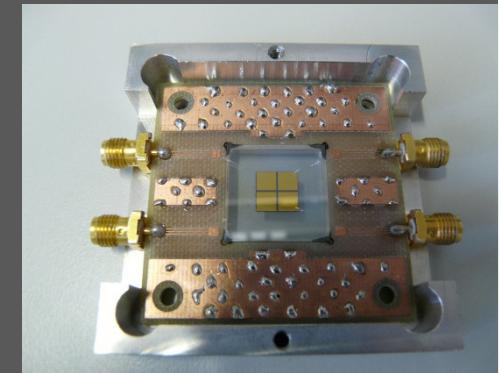
1Grad = 10<sup>7</sup> Gy

# Diamond in-beam tests

Feb 2014

First test of (E6) pcCVD-DD samples at ACCULINNA separator with 40.5 MeV/u  $^{40}\text{Ar}$  beam

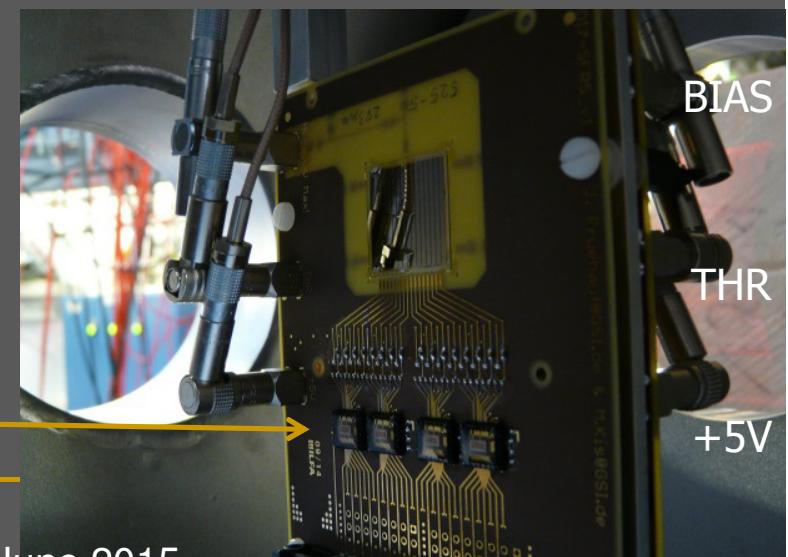
- 4 Al contacts,  $\Delta E \sim 20\text{-}600$  MeV (DBA amp,  $V_{in} < 50$  mV)
- total rate  $10^{11}$  ions/cm $^2$ , test with  $\alpha$  particles



Aug 2014

First ToF measurements at FRS with 900 MeV/u  $^{197}\text{Au}$  beam  
with (E6) pcCVD-DD 20x20x0.3 mm $^3$

- 16-strip design: (1x18) mm $^2$  each (0.15 mm gap),  $C = 4.3$  pF/stripe
- metallization: 50nm/100nm (Cr/Au) by photolithography (GSI-DL)
- PADI7, gain ~250, 4x4chs



# Electronics with ToT capability

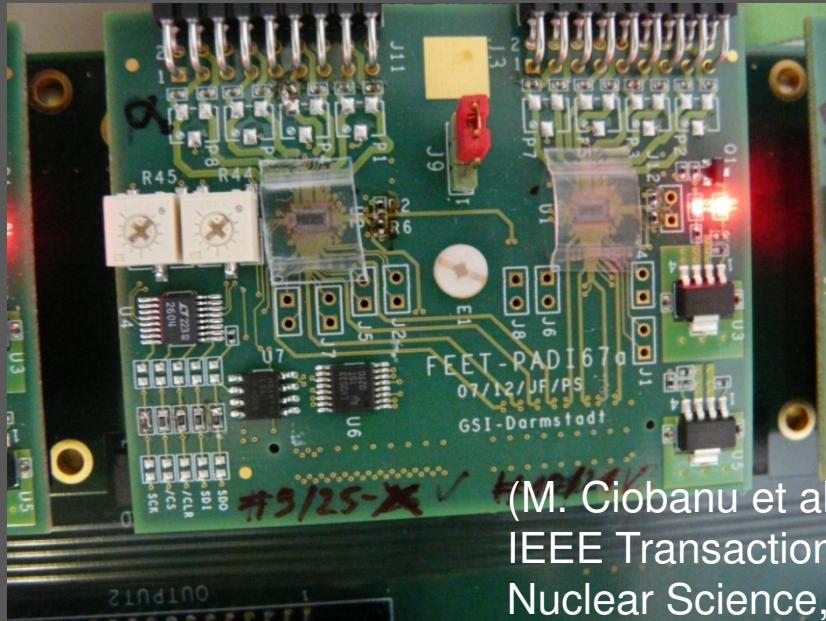
- **PADI** ASIC 0.18  $\mu\text{m}$  CMOS

- rise time < 500 ps
- $30 \text{ fC} < Q < 2000 \text{ fC}$
- $\sigma_{tE} < 15 \text{ ps}$
- LVDS digital outputs
- 350 MHz bandwidth



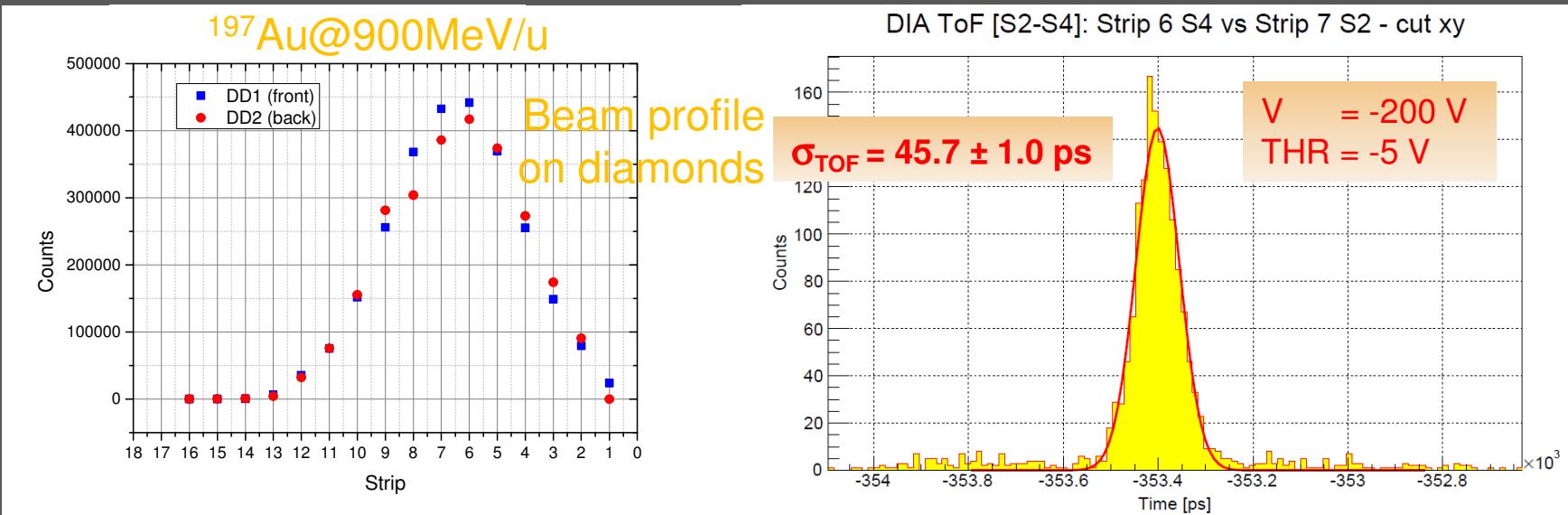
- **VFTX** (28 chs) VME FPGA TDC

- LVDS inputs
- 200 MHz clock (external & internal)
- $\sigma_t < 10 \text{ ps}$



(M. Ciobanu et al.,  
IEEE Transactions on  
Nuclear Science,  
vol.58, no. 4, p. 2073,  
Aug. 2011)

# $\sigma_{\text{intr}}$ contribution



## S2-S4 Detector resolution

$$\sigma_{DD} = \sqrt{\sigma_{ToF}^2 - \sigma_j^2} = \sqrt{(45.7)^2 - (15)^2} = 43.2 \text{ ps}$$

$$\sigma_{\text{intr},\text{DD1}} = 25 \text{ ps}$$

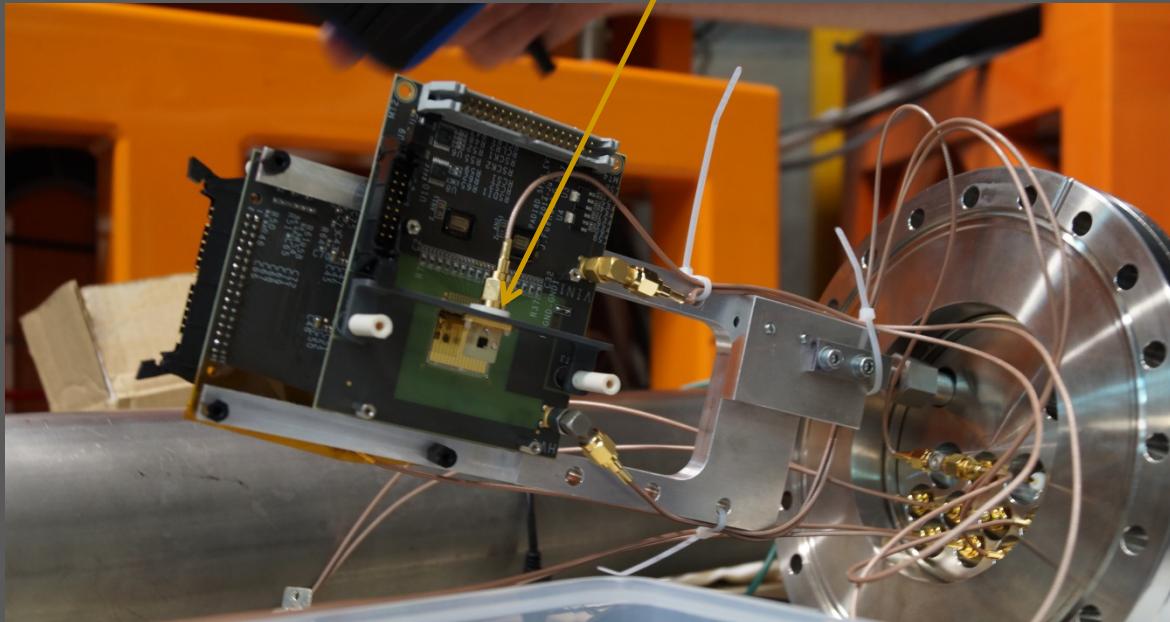
$$\sigma_{\text{intr},\text{DD2}} = 35 \text{ ps}$$

Measured PADI/VFTX intrinsic time resolution: 15 ps ( $\sigma$ )

# Irradiation test at LNS-INFN

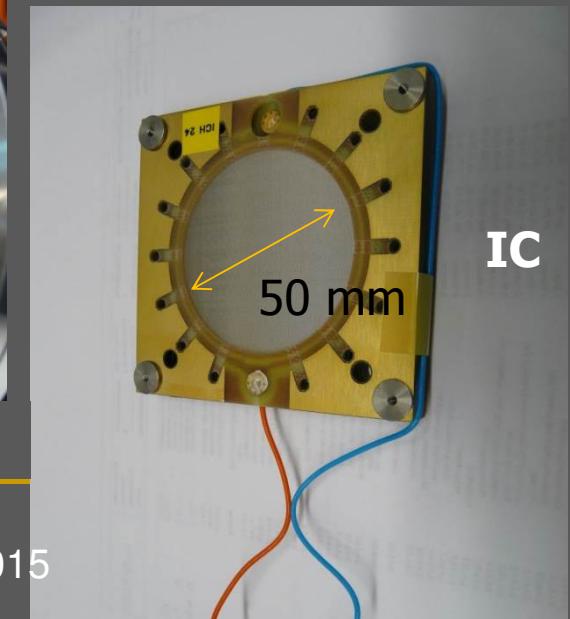
May 2015

Series of irradiation of  $10^7$   $^{12}\text{C}/\text{mm}^2 \text{ s}$  @62 MeV/u followed by data taking via digital scope (10 GS/s) at low rate to monitor the time resolution and CCE of pcCVD-DD (0.3mm) and scCVD-DD (0.09mm)

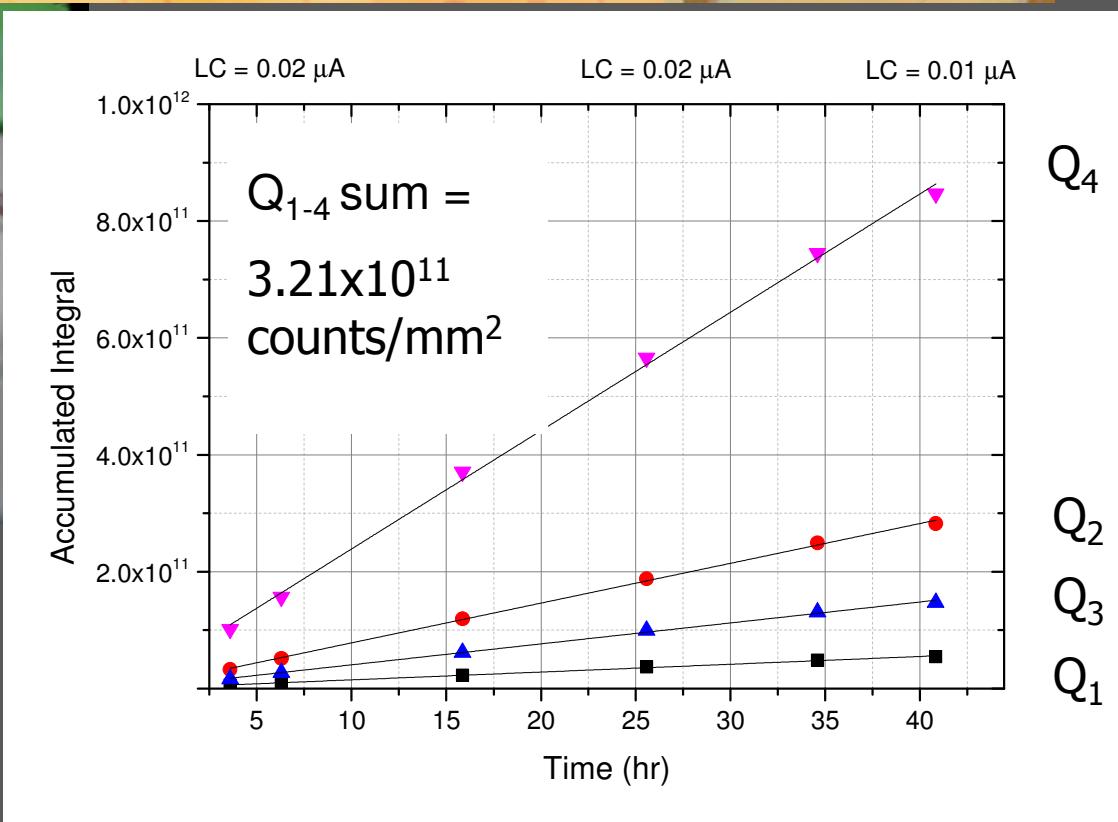
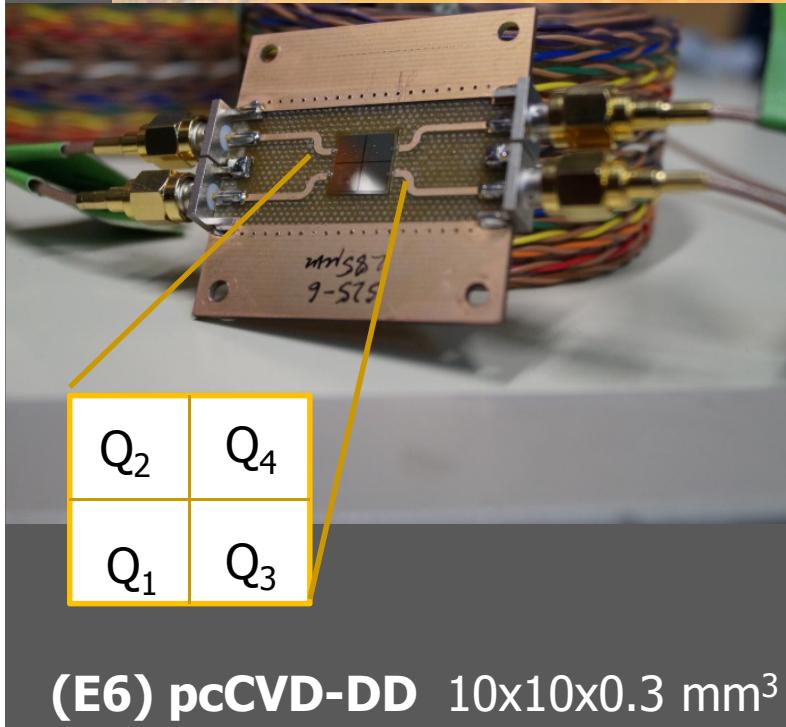


- beam current measured by ionization chamber IC

- new chip **PADI7D**, 8x2 chs (distance reduced), new threshold control



# Preliminary results (run with collim.)

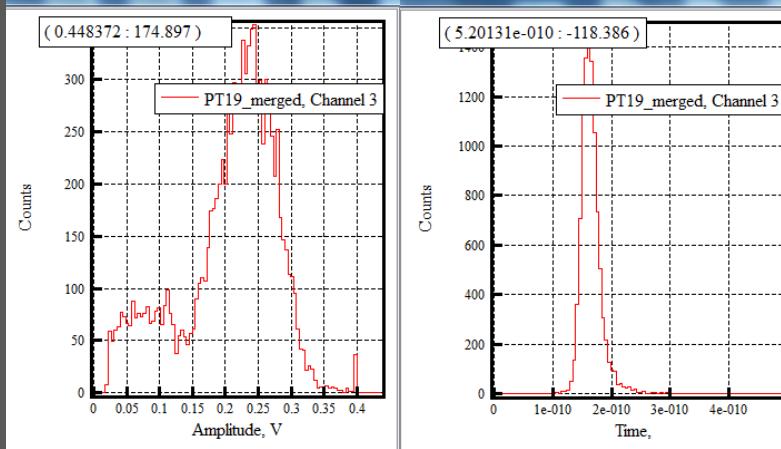


Minimum absorbed dose =  $1.8 \times 10^6$  Gy ( $^{12}\text{C}$ @62 MeV/u)

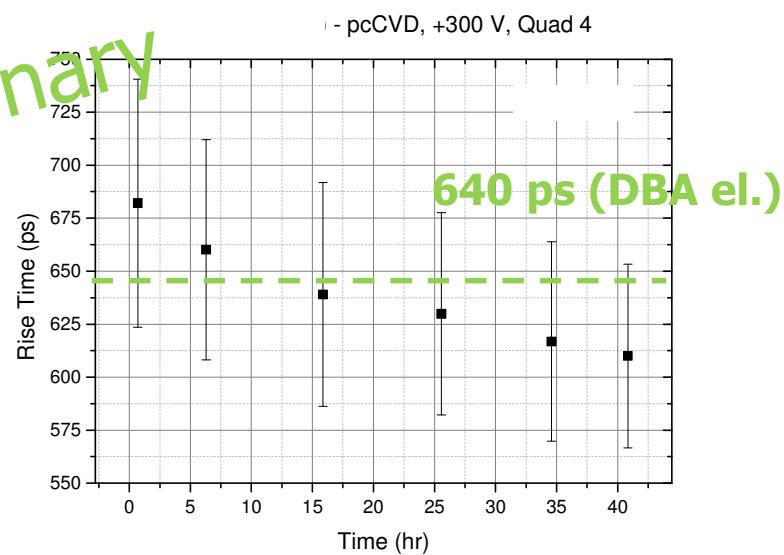
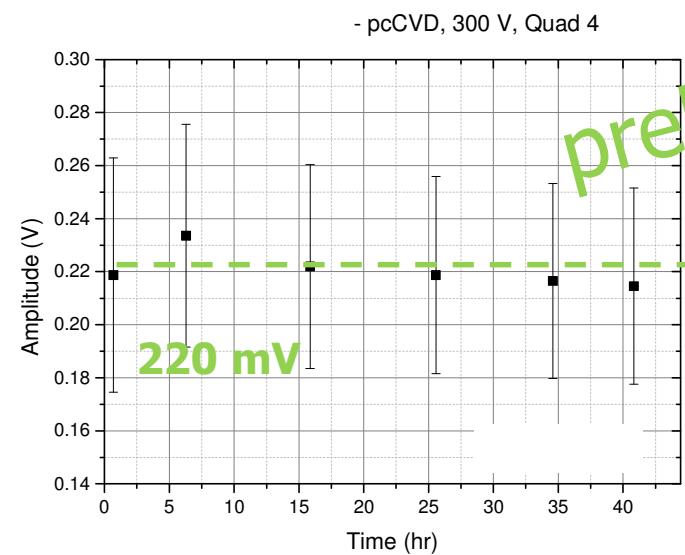
≈400 days operation

# Digital waveform analysis

$^{12}\text{C}$ @62MeV/u



after 40 hours



# Summary

- The in-flight magnetic separator **Super-FRS** under construction at FAIR is ideal for the next-generation experiments with RIBs
- ToF detectors are crucial to obtain a clean PID; results of in-beam tests of **strip diamond detectors** (processed in house) performed in conditions similar to that of the Super-FRS show that  $\sigma_t \sim 25 \text{ ps}$  is achievable
- Preliminary results of **irradiation tests** on pcCVD-DD sample does not show any damage after an absorbed dose of  $1.8 \times 10^6 \text{ Gy}$ .

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